

Data-driven Modelling for Power Module Condition Monitoring

TWIND Online Summer School

08/July/2021

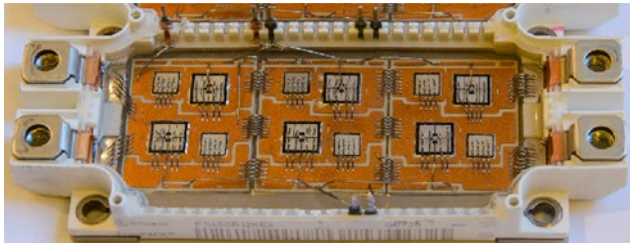
Chunjiang Jia (CJ)

Agenda

- Power module failure mechanism
- Heat flux detection method
- Artificial neural network
- ANN-based heat flux detection
- Test and verification
- Summary

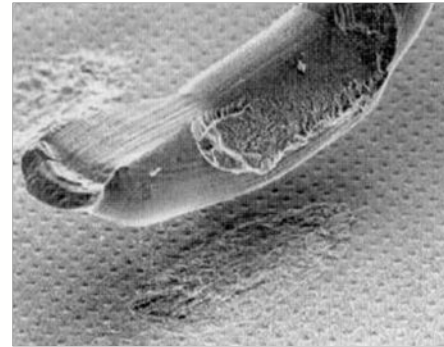
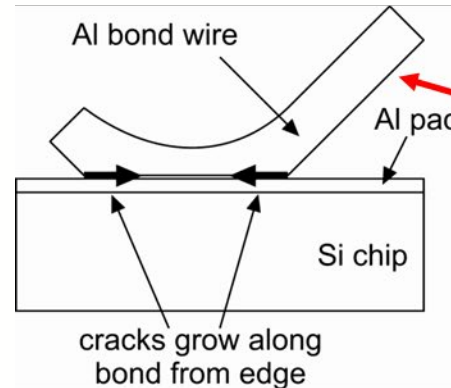
Power Module Failure Mechanism

Col. A



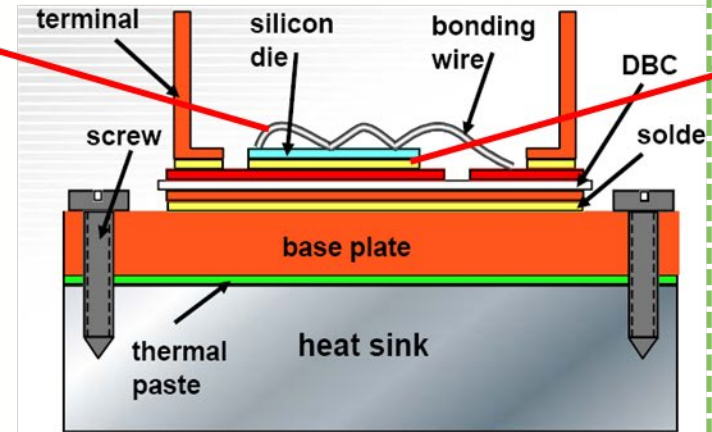
Col. B

Bond wire lift-off



Col. C

Thermo-mechanical stress accumulation



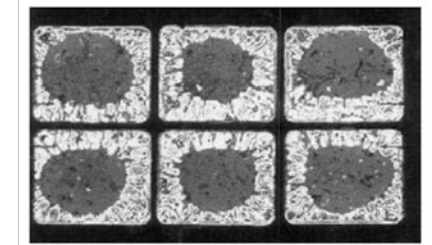
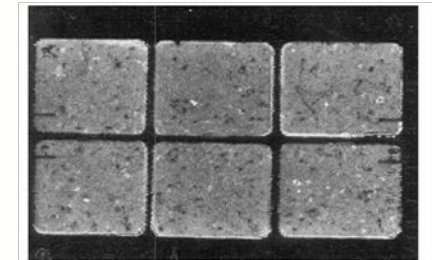
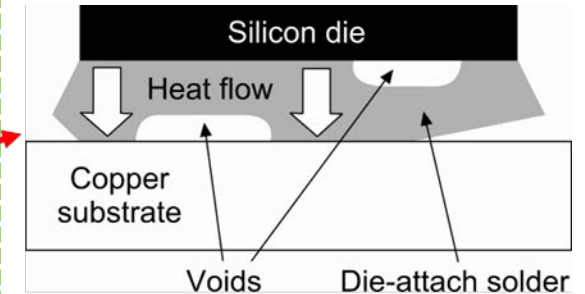
Coefficient of Thermal Expansion (CTE)	
silicon	$4.1 \times 10^{-6} \text{K}^{-1}$
DBC - Al ₂ O ₃	$7.4 \times 10^{-6} \text{K}^{-1}$
copper	$17.5 \times 10^{-6} \text{K}^{-1}$

Solder SAC₃₀₅

$23 \times 10^{-6} \text{K}^{-1}$

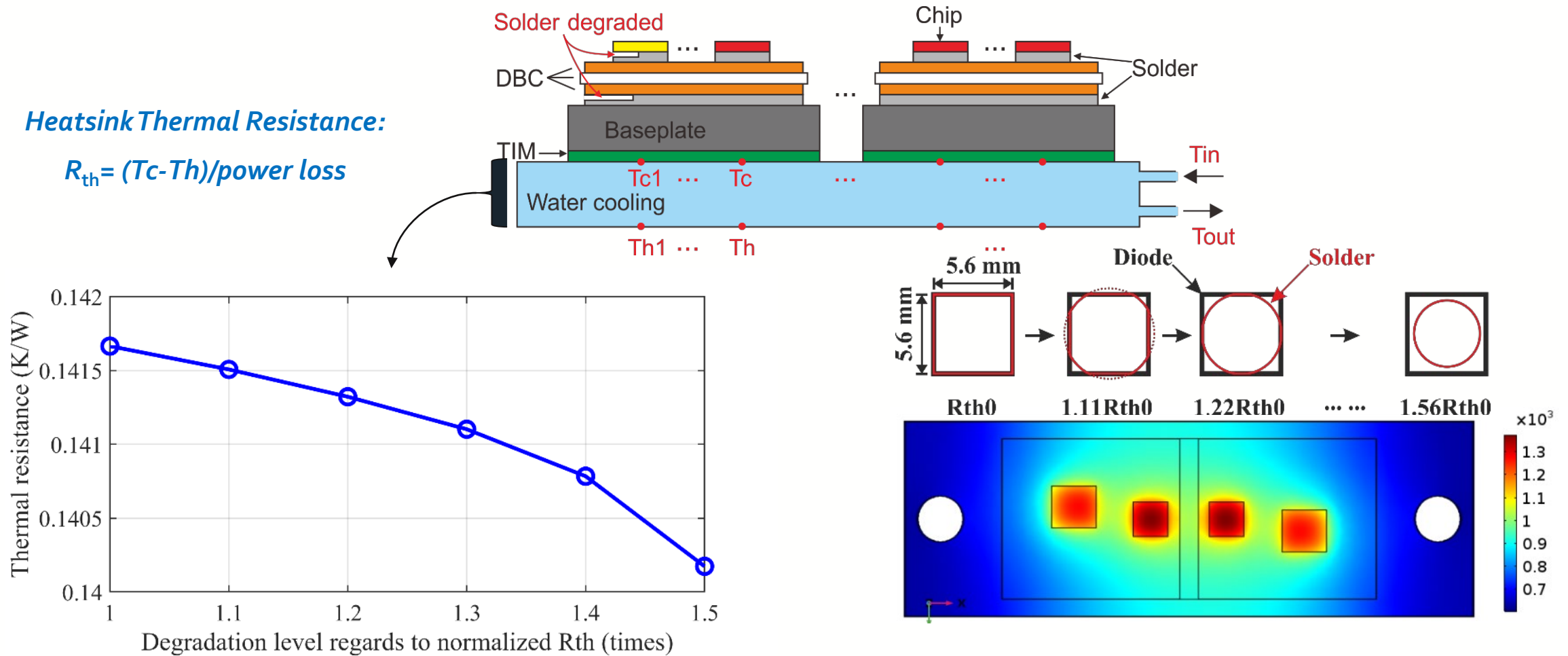
Col. D

Solder delamination



Detection methods:

- TSEP, thermal sensitive electrical parameter to monitor the degradation
- Heat flux, the degradation causes the R_{th} of thermal path to increase, which will influence the heat transfer rate through the layers

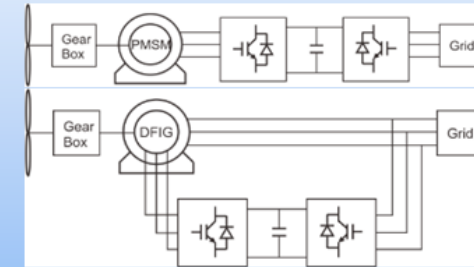


- ❑ When the degradation happens to the solder, the temperature drop is becoming larger from chip to heatsink, causing R_{th} decreasing
- ❑ The mapping between the temperature distribution (thermal) and the operating point (electric) can be used to indicate the level of solder degradation

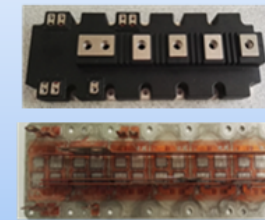
Thermal Resistance: $R_{th} = \Delta T / \text{power loss}$

- ❑ Electric performances (power loss related) of power modules are temperature dependent
 - An electric and thermal coupled result
- ❑ Degradation is a non-linear and multiphysics process for multi-chip power modules
 - A complex thermal network model with multiple-input and multiple-out (MIMO)
 - A large number of look-up tables required
- ❑ Therefore, it is challenge to develop a model-based analytical method to implement heat flux condition monitoring online for multi-chip power modules

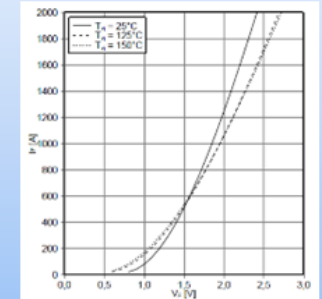
Electro-thermal modelling



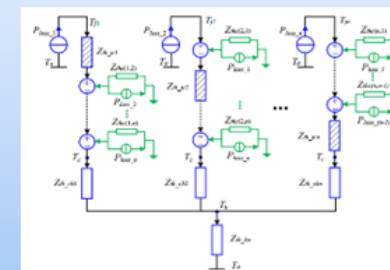
Uneven degradation



Multi-chip in MW module

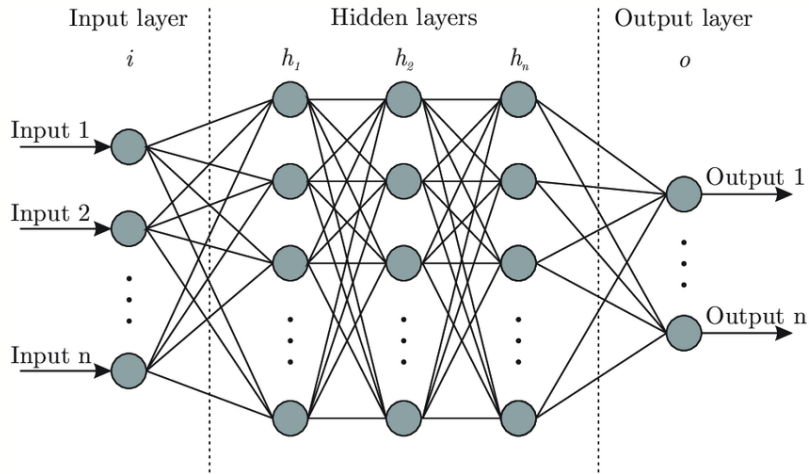


Coupling analysis



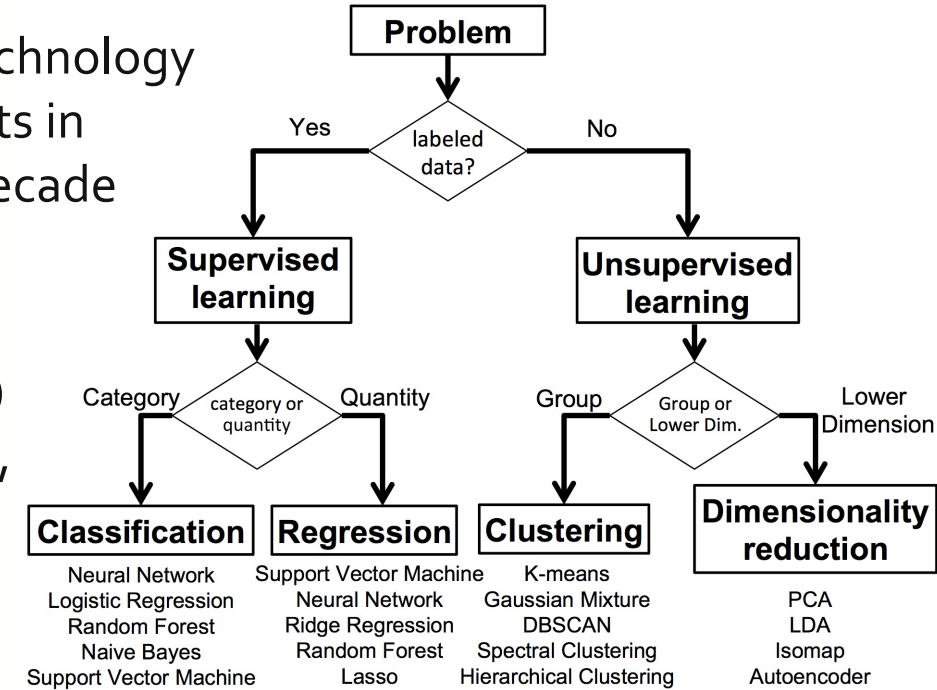
- Current sharing
- Power losses
- Thermal runaway

The on-line solution for thermal-mechanical performance is complex.

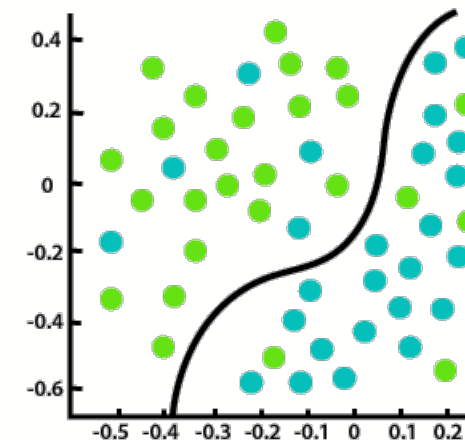


❑ Data-driven machine learning technology has achieved extraordinary results in numerous domains in the past decade

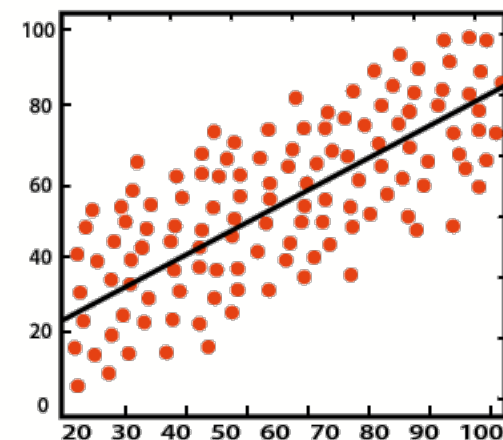
❑ Artificial Neural Networks (ANN) have found success in regression, classification and clustering problems



- ❑ Introduction of ANN into heat flux detection could provide a feasible method to monitor power module degradation
- ANN structure with available features as input and output
 - Regression model to describe the mechanism
 - Classification model to identify the degradation level



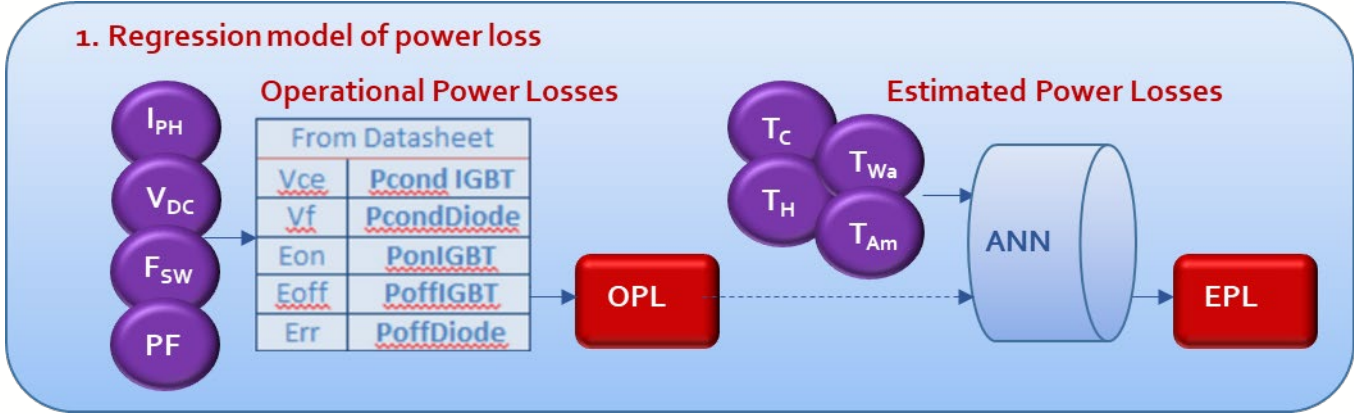
Classification



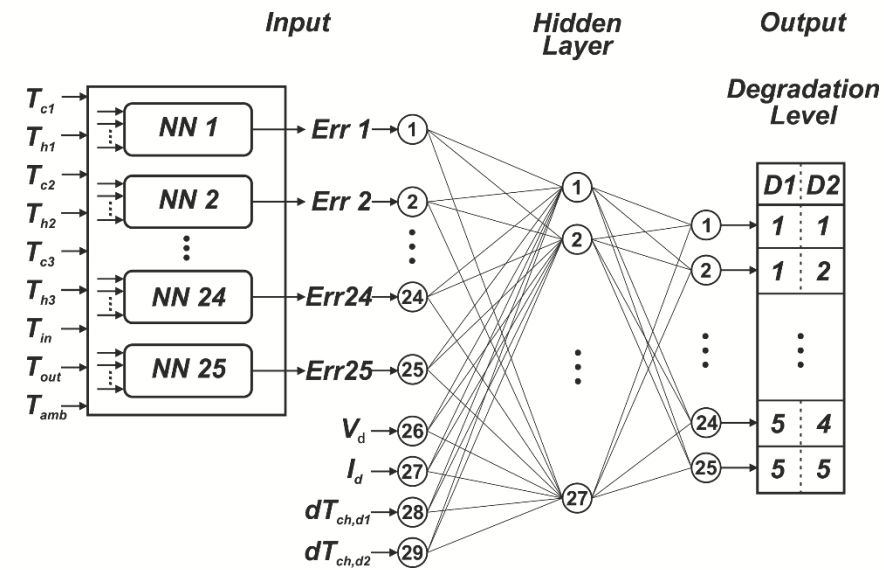
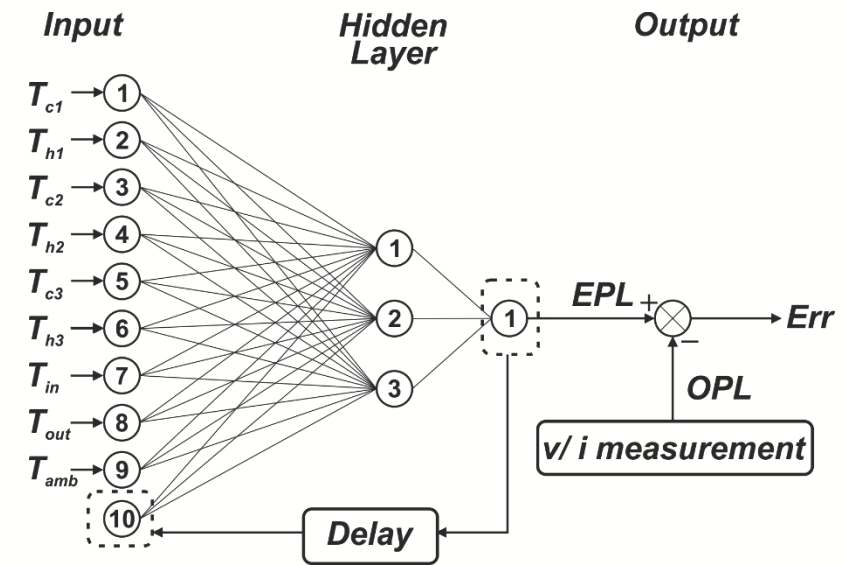
Regression

Supervised machine learning with labelled data

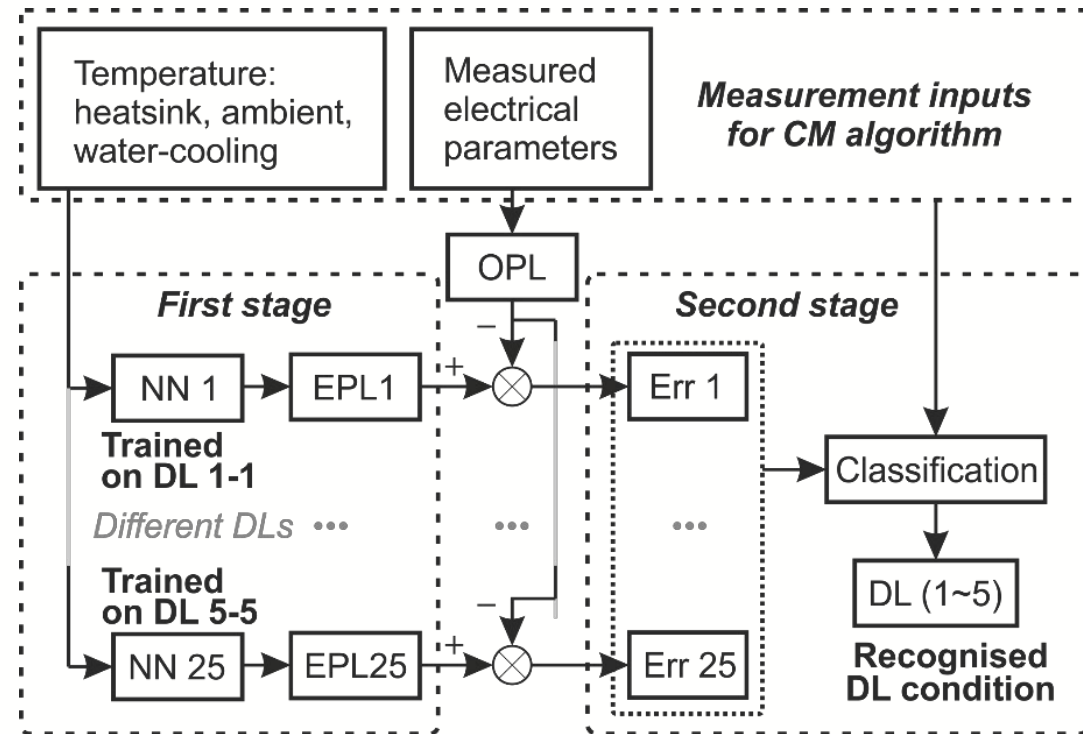
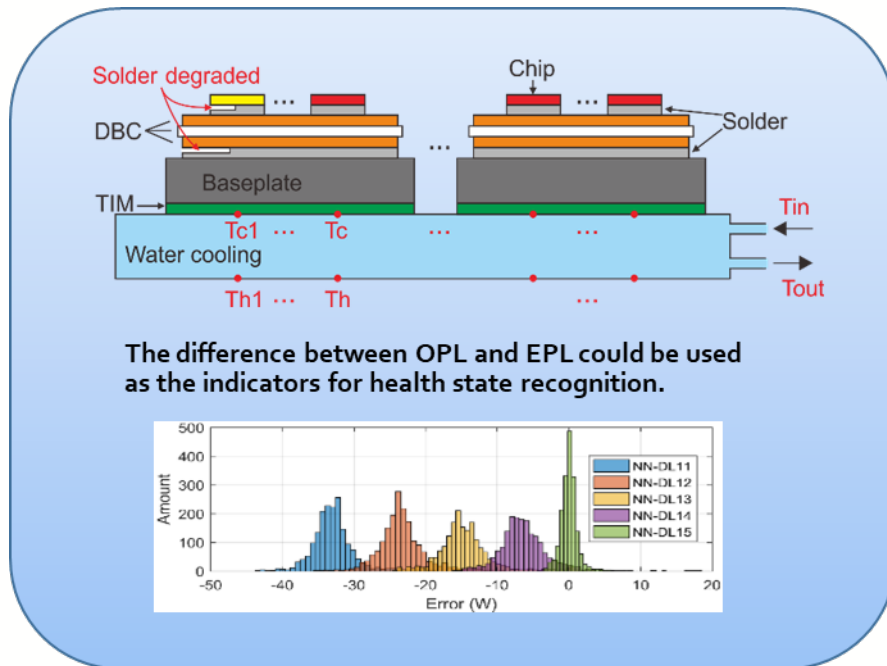
First stage: Regression model to quantify the power loss

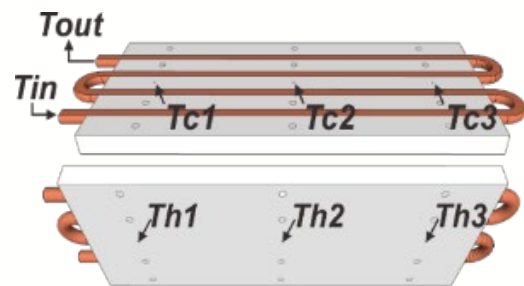
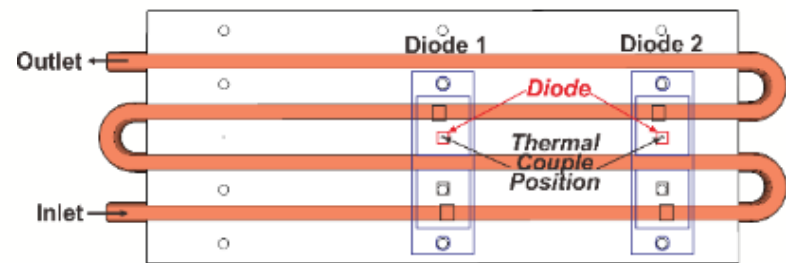


Second stage: Classification model to differentiate degradation level

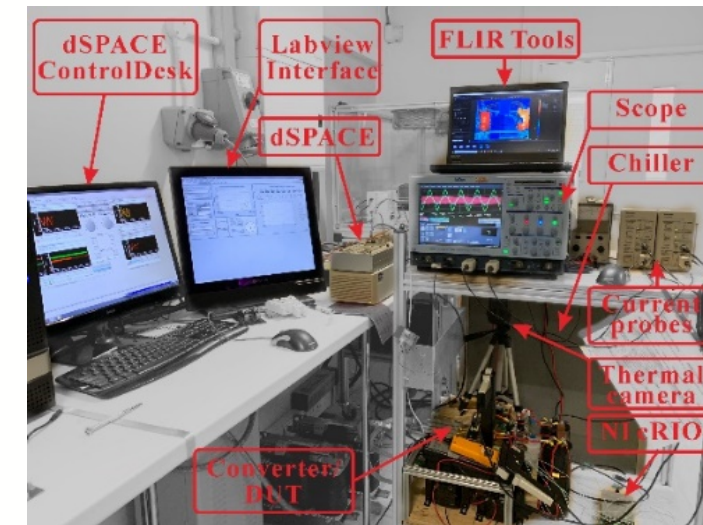
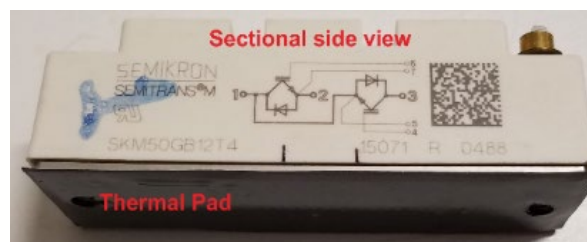
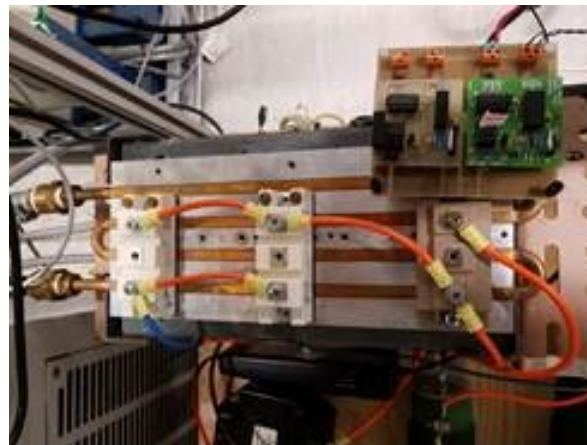
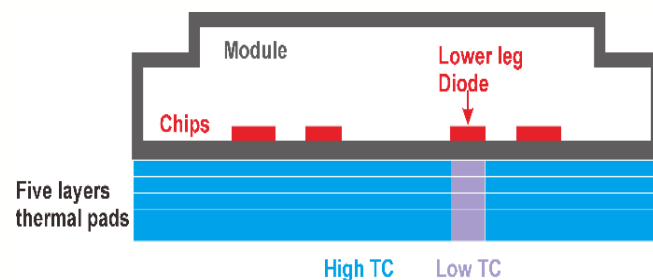


- First stage: a series of sub-NNs (neural networks), representing a **certain pattern** at different DL (degradation level). For a given **electrical operating point** labeled by OPL (operational power loss), the power losses inside the module will create a **temperature distribution** under this DL.
- Second stage: one NN with the inputs from all the sub-NNs at first stage to **recognise** the pattern of electrical operating point and temperature distribution and **differentiate** the related DL.





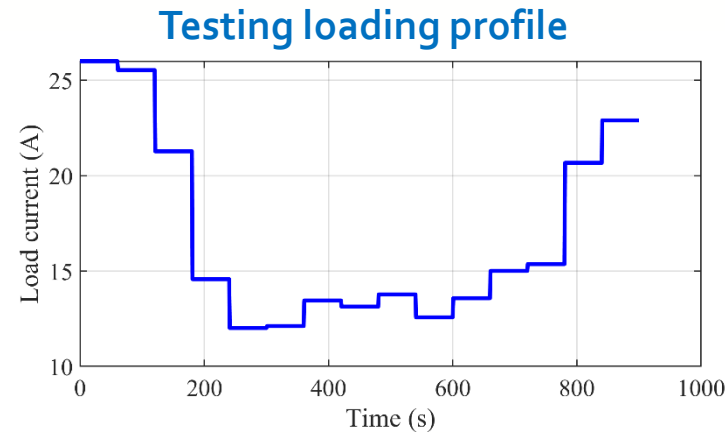
Bottom surface



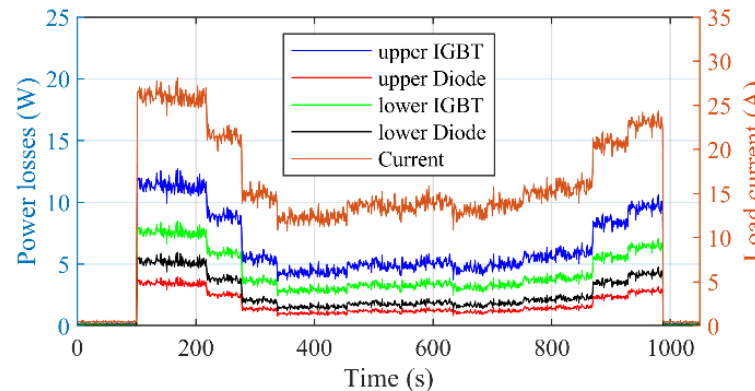
Degradation level	Number of low TC pads	Junction to case thermal resistance (K/W)	Normalized thermal resistance
DL 0	0	0.946	1 (initial state)
DL 1	1	1.052	1.112
DL 2	2	1.158	1.224
DL 3	3	1.264	1.336
DL 4	4	1.370	1.448
DL 5	5	1.476	1.560

Experimental Verification Result 2

- At each degradation level (DL1...5), apply loading current profile



- Record thermal and electrical parameters to validate the trained ANN model



Tested output degradation level	DL 0	DL 1	DL 2	DL 3	DL 4	DL 5	
	537 8.9%	1055 17.6%	1 0.0%	0 0.0%	0 0.0%	0 0.0%	33.7% 66.3%
	0 0.0%	0 0.0%	0 0.0%	0 0.0%	0 0.0%	0 0.0%	NaN% NaN%
	1 0.0%	0 0.0%	245 4.1%	0 0.0%	1 0.0%	11 0.2%	95.0% 5.0%
	0 0.0%	0 0.0%	771 12.8%	1062 17.7%	10 0.2%	0 0.0%	57.6% 42.4%
	0 0.0%	0 0.0%	11 0.2%	28 0.5%	727 12.1%	0 0.0%	94.9% 5.1%
Pre-set target degradation level	DL 0	DL 1	DL 2	DL 3	DL 4	DL 5	
	99.8% 0.2%	0.0% 100%	23.6% 76.4%	97.4% 2.6%	60.9% 39.1%	99.0% 1.0%	60.8% 39.2%

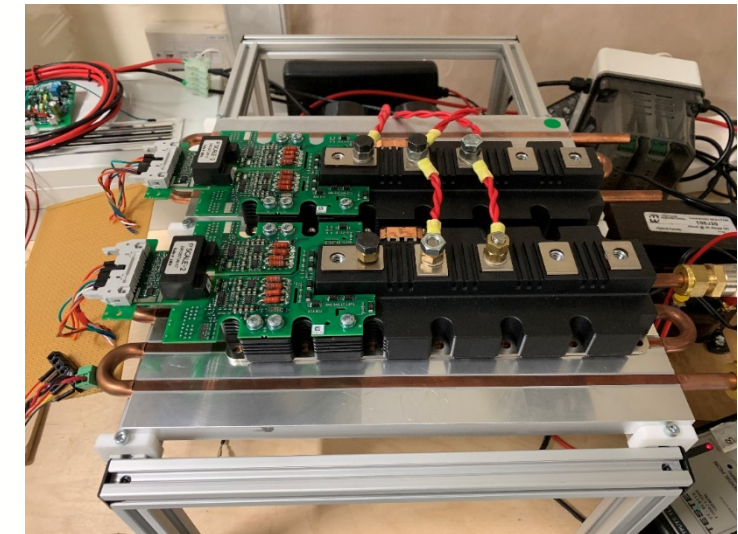
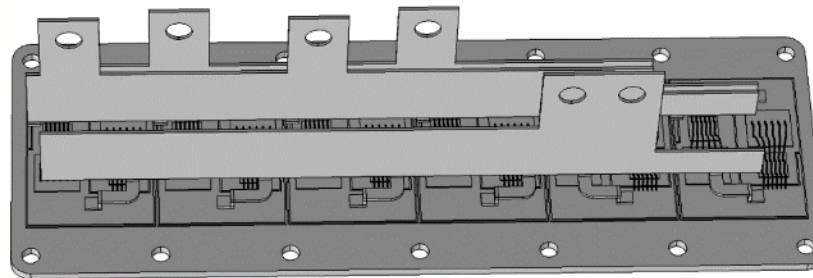
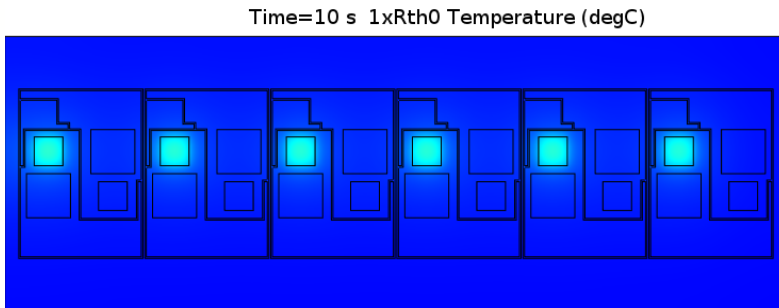
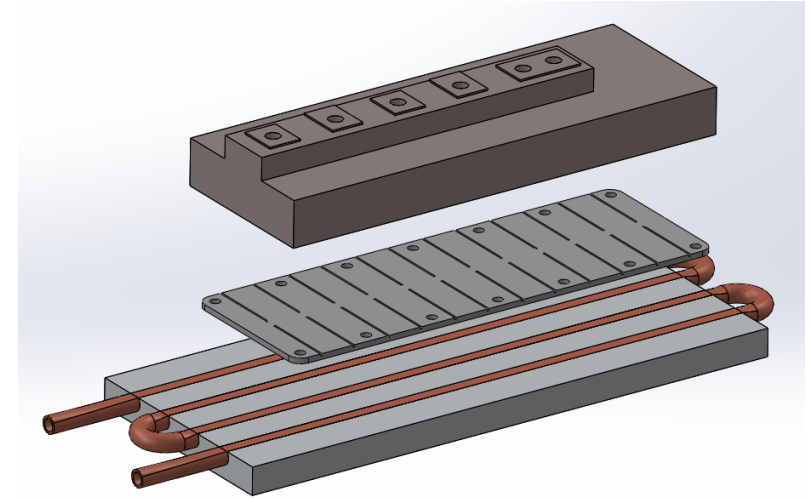
Deep NN



537 8.9%	0 0.0%	1 0.0%	0 0.0%	0 0.0%	0 0.0%	99.8% 0.2%
0 0.0%	1055 17.6%	0 0.0%	0 0.0%	0 0.0%	0 0.0%	100% 100%
1 0.0%	0 0.0%	1016 16.8%	0 0.0%	1 0.0%	11 0.2%	95.0% 5.0%
0 0.0%	0 0.0%	11 0.2%	1062 17.7%	10 0.2%	0 0.0%	98.1% 1.9%
0 0.0%	0 0.0%	12 0.2%	28 0.5%	1182 19.6%	0 0.0%	94.9% 5.1%
0 0.0%	0 0.0%	0 0.0%	0 0.0%	0 0.0%	1083 18.0%	100% 100%
99.8% 0.2%	100% 0.0%	97.8% 2.2%	97.4% 2.6%	99.1% 0.9%	99.0% 1.0%	98.8% 1.2%
DL0	DL1	DL2	DL3	DL4	DL5	

Pre-set target degradation level

- The deep NN-based heat flux detection method is proposed to monitor the module degradation
- The proposed method can successfully detect the degradation level even under complex operating conditions
- Future work is to verify the method with a more complicated multi-chip power module, i.e., PrimePack IGBT module



Contact us

GLASGOW

Inovo

121 George Street
Glasgow
G1 1RD

T +44 (0)333 004 1400



BLYTH

National Renewable Energy Centre

Offshore House
Albert Street
Blyth, Northumberland
NE24 1LZ

T +44 (0)1670 359 555



LEVENMOUTH

Fife Renewables Innovation Centre (FRIC)

Ajax Way
Leven
KY8 3RS

T +44 (0)1670 359 555



HULL

O&M Centre of Excellence

Ergo Centre
Bridgehead Business Park
Meadow Road, Hessle
HU13 0GD

